

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

| Characteristic | | | Symbol | Value | Units |
|-----------------------------------------------------------|--------------|--------------------------------------------------|------------------|--------------|-------|
| Drain-Source Voltage | | | V _{DSS} | -12 | V |
| Gate-Source Voltage | | | V _{GSS} | ±8 | V |
| Continuous Drain Current (Note 6) V _{GS} = -4.5V | Steady State | T _A = +25°C T _A = +70°C | I _D | -4.0 -3.1 | A |
| Continuous Drain Current (Note 6) V _{GS} = -2.5V | Steady State | T _A = +25°C T _A = +70°C | I _D | -3.3 -2.6 | A |
| Continuous Drain Current (Note 7) V _{GS} = -4.5V | Steady State | T _A = +25°C T _A = +70°C | I _D | -5.2 -4.2 | A |
| Continuous Drain Current (Note 7) V _{GS} = -2.5V | Steady State | T _A = +25°C T _A = +70°C | I _D | -4.3 -3.4 | A |
| Maximum Continuous Body Diode Forward Current (Note 7) | | | I _S | -2 | A |
| Pulsed Drain Current (10μs pulse, duty cycle=1%) (Note 6) | | | I _{DM} | -40 | A |

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Value | Units |
|--------------------------------------------------|-----------------------------------|-------------|-------|
| Total Power Dissipation (Note 6) | P _D | 0.8 | W |
| Thermal Resistance, Junction to Ambient (Note 6) | R _{θJA} | 168 | °C/W |
| Total Power Dissipation (Note 7) | P _D | 1.3 | W |
| Thermal Resistance, Junction to Ambient (Note 7) | R _{θJA} | 99 | °C/W |
| Thermal Resistance, Junction to Case (Note 7) | R _{θJC} | 14.8 | °C/W |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55 to +150 | °C |

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
|--------------------------------------------------------|---------------------|------|-------|------|------|--------------------------------------------------------------------------------------------------|
| OFF CHARACTERISTICS (Note 8) | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | -12 | — | — | V | V _{GS} = 0V, I _D = -250μA |
| Zero Gate Voltage Drain Current T _J = +25°C | I _{DSS} | — | — | -1.0 | μA | V _{DS} = -12V, V _{GS} = 0V |
| Gate-Source Leakage | I _{GSS} | — | — | ±10 | μA | V _{GS} = ±8V, V _{DS} = 0V |
| ON CHARACTERISTICS (Note 8) | | | | | | |
| Gate Threshold Voltage | V _{GS(th)} | -0.3 | -0.55 | -1.0 | V | V _{DS} = V _{GS} , I _D = -250μA |
| Static Drain-Source On-Resistance | R _{DS(on)} | — | 26 | 31 | mΩ | V _{GS} = -4.5V, I _D = -4.0A |
| | | | 31 | 45 | | V _{GS} = -2.5V, I _D = -3.5A |
| | | | 45 | 75 | | V _{GS} = -1.8V, I _D = -2.7A |
| | | | — | — | | V _{GS} = -1.8V, I _D = -2.7A |
| Forward Transfer Admittance | Y _{fs} | — | 12 | — | S | V _{DS} = -5V, I _D = -4A |
| Diode Forward Voltage | V _{SD} | — | -0.6 | — | V | V _{GS} = 0V, I _S = -1A |
| DYNAMIC CHARACTERISTICS (Note 9) | | | | | | |
| Input Capacitance | C _{iss} | — | 1357 | — | pF | V _{DS} = -10V, V _{GS} = 0V f = 1.0MHz |
| Output Capacitance | C _{oss} | — | 504 | — | pF | |
| Reverse Transfer Capacitance | C _{rss} | — | 235 | — | pF | |
| Gate Resistnace | R _g | — | 14.1 | — | Ω | V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz |
| SWITCHING CHARACTERISTICS (Note 9) | | | | | | |
| Total Gate Charge | Q _g | — | 15.8 | — | nC | V _{GS} = -4.5V, V _{DS} = -10V, I _D = -4A |
| Gate-Source Charge | Q _{gs} | — | 2.0 | — | nC | |
| Gate-Drain Charge | Q _{gd} | — | 3.9 | — | nC | |
| Turn-On Delay Time | t _{D(on)} | — | 15.7 | — | ns | V _{DS} = -10V, V _{GS} = -4.5V, R _L = 2.5Ω, R _G = 3.0Ω |
| Turn-On Rise Time | t _r | — | 23.3 | — | ns | |
| Turn-Off Delay Time | t _{D(off)} | — | 91.2 | — | ns | |
| Turn-Off Fall Time | t _f | — | 106.9 | — | ns | |

- Notes:
6. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
 7. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate
 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to production testing.

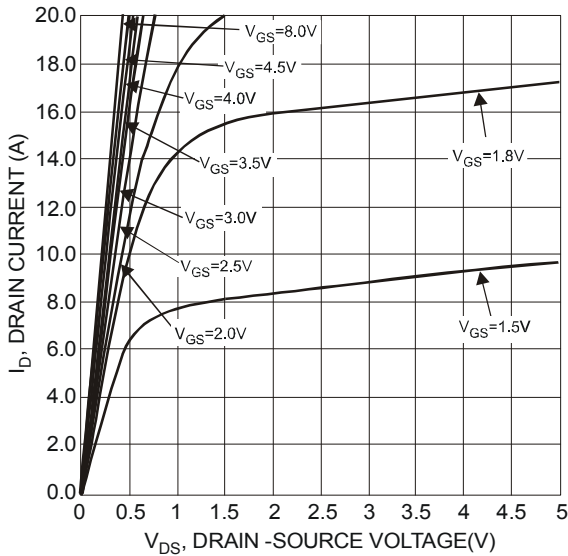


Fig. 1 Typical Output Characteristics

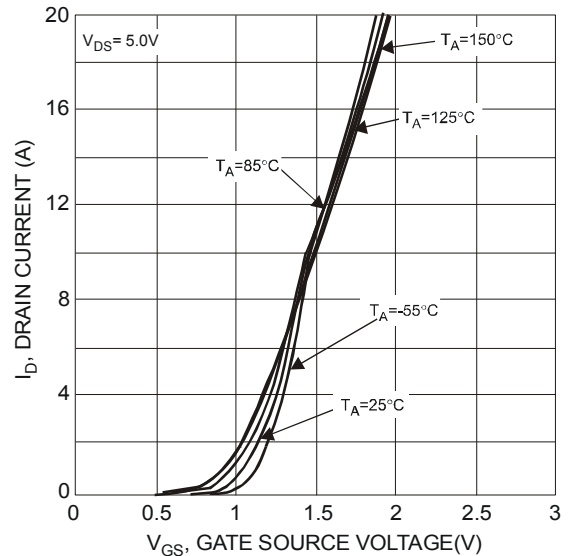


Fig. 2 Typical Transfer Characteristics

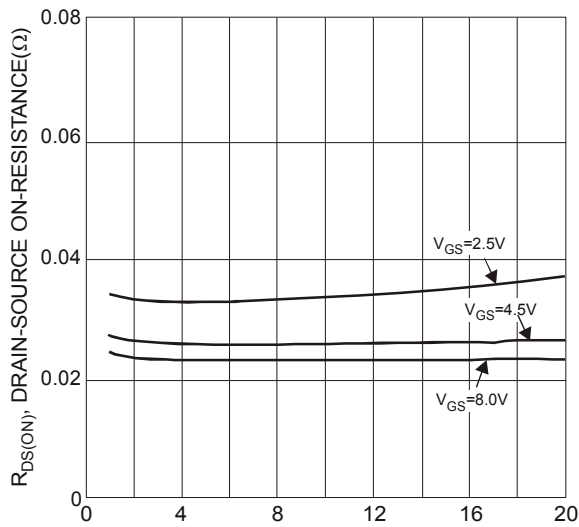


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

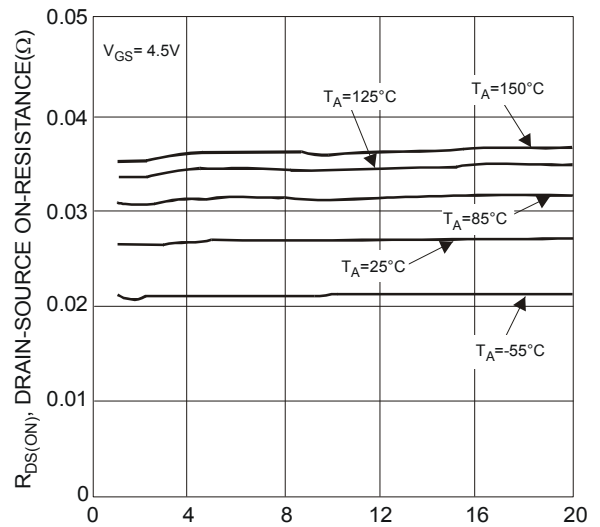


Fig. 4 Typical On-Resistance vs. Drain Current and Temperature

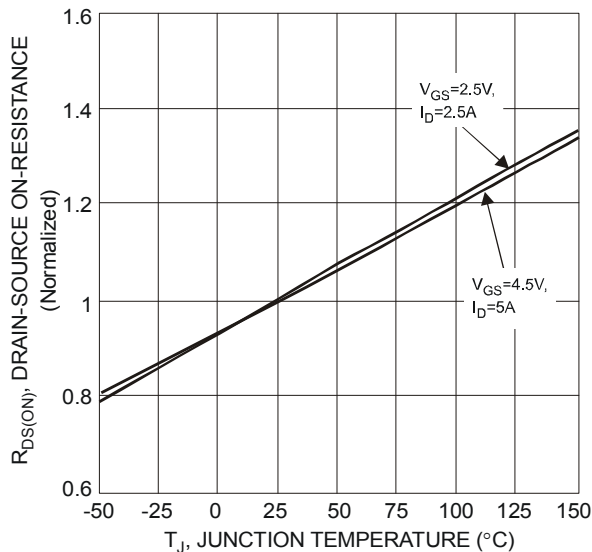


Fig. 5 On-Resistance Variation with Temperature

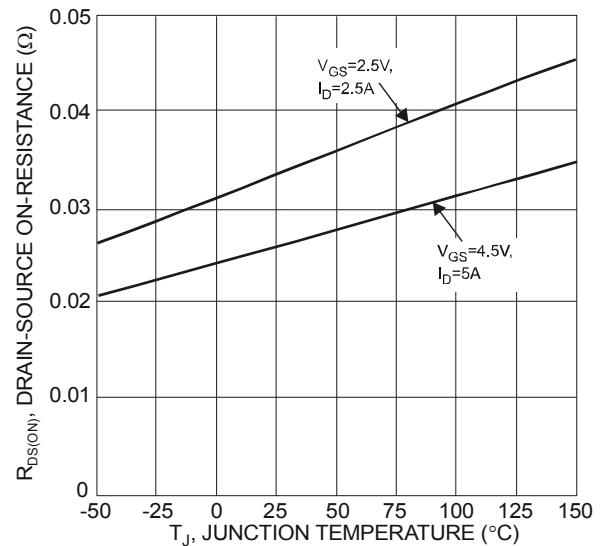


Fig. 6 On-Resistance Variation with Temperature

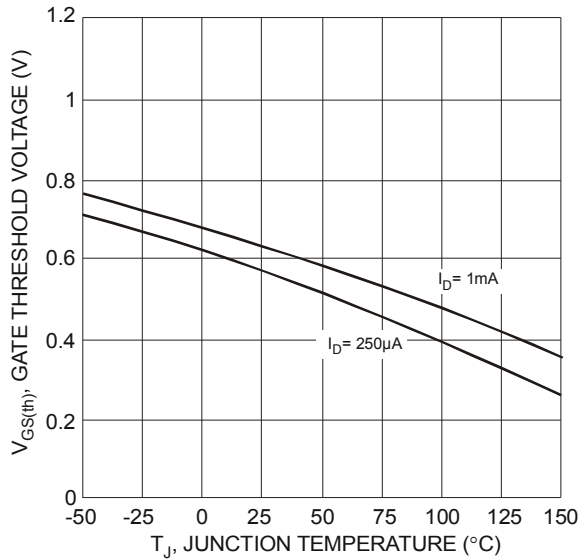


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

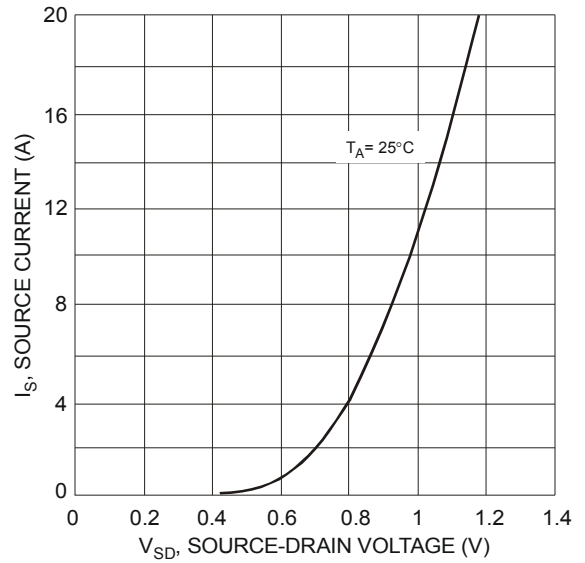


Fig. 8 Diode Forward Voltage vs. Current

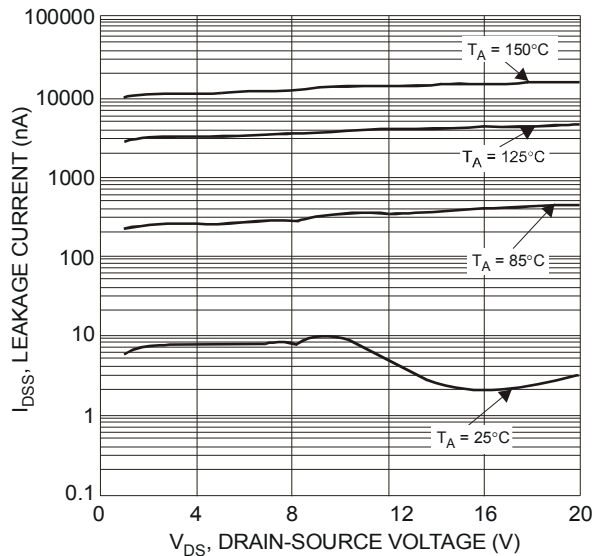


Fig. 9 Typical Drain-Source Leakage Current vs. Voltage

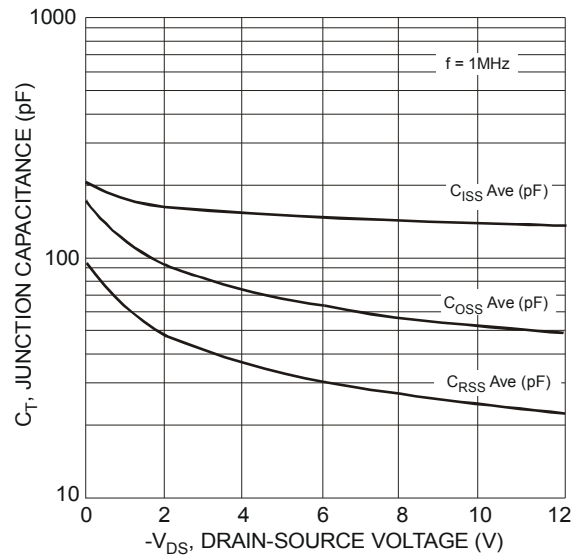


Fig. 10 Typical Junction Capacitance

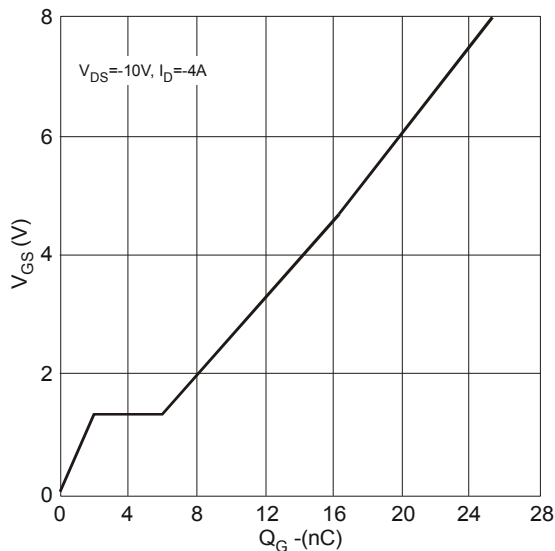
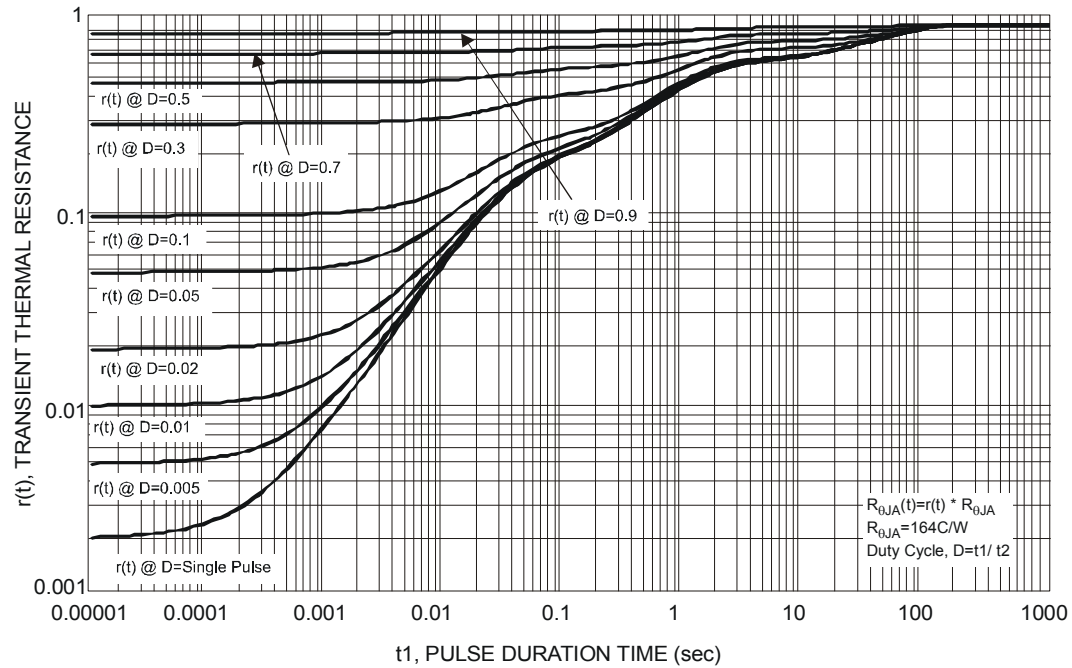
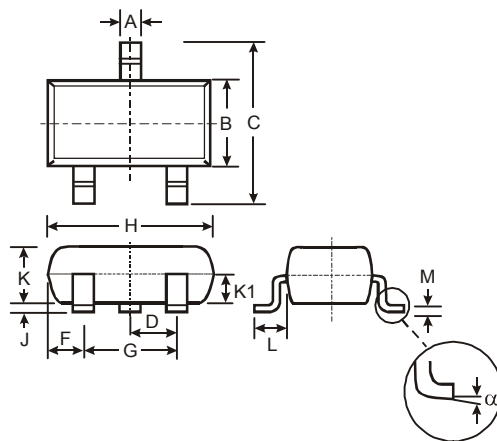


Fig. 11 Gate Charge Characteristics



Package Outline Dimensions

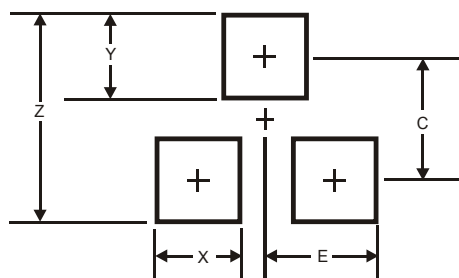
Please see AP02002 at <http://www.diodes.com/datasheets/ap02002.pdf> for latest version.



| SOT23 | | | |
|----------------------|-------|------|-------|
| Dim | Min | Max | Typ |
| A | 0.37 | 0.51 | 0.40 |
| B | 1.20 | 1.40 | 1.30 |
| C | 2.30 | 2.50 | 2.40 |
| D | 0.89 | 1.03 | 0.915 |
| F | 0.45 | 0.60 | 0.535 |
| G | 1.78 | 2.05 | 1.83 |
| H | 2.80 | 3.00 | 2.90 |
| J | 0.013 | 0.10 | 0.05 |
| K | 0.903 | 1.10 | 1.00 |
| K1 | - | - | 0.400 |
| L | 0.45 | 0.61 | 0.55 |
| M | 0.085 | 0.18 | 0.11 |
| α | 0° | 8° | - |
| All Dimensions in mm | | | |

Suggested Pad Layout

Please see AP02001 at <http://www.diodes.com/datasheets/ap02001.pdf> for latest version.



| Dimensions | Value (in mm) |
|------------|---------------|
| Z | 2.9 |
| X | 0.8 |
| Y | 0.9 |
| C | 2.0 |
| E | 1.35 |

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